			Application/0	10/700 000 F		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
Notice of References Cited							
				Examiner	Examiner		
				Helen L. Pez	Helen L. Pezzuto		Page 1 of 1
U.S. PATENT DOCUMENTS							
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name			Classification
	Α	US-					
	В	US-					
	С	US-					
	D	US-					
	Е	US-					
	F	US-					
	G	US-					
	Н	US-					
	1	US-					
	J	US-					
	К	US-					
	L	US-					
	М	US-					
FOREIGN PATENT DOCUMENTS							
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Na	ame	Classification
	N						
	0						
	Р						
	a						
	R						
	S						
	Т						
NON-PATENT DOCUMENTS							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Chen et al. Jorunal of Applied Polymer Science (2005), 98(1), 109-115.

W

Х